

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ERDELEN ET AL.	
		Examiner Alton N. Pryor	Art Unit 1616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,730,312	05-2004	Schneidersmann et al.	424/405
*	B	US-6,680,325	01-2004	Erdelen et al.	514/269
	C	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	JP-1104617 (ABS)	02-1999	JP	Tanaka et al	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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